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Identification cards — Card service life — Part 2: Methods of evaluation

*Cartes d'identification — Durée de vie des cartes —
Partie 2: Méthodes d'évaluation*

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Foreword

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ISO/IEC 24789 consists of the following parts, under the general title *Identification cards — Card service life*:

- *Part 1: Application profiles and requirements*
- *Part 2: Methods of evaluation*

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Introduction

This part of ISO/IEC 24789 comprises methods of evaluation of identification (ID) card service life.

These methods of evaluation complement the application profiles and requirements defined in ISO/IEC 24789-1, which are intended to be used by card issuers, card manufacturers and card component suppliers to represent the comparative rigour of various ID card service life applications. They provide a means for ranking and comparing the main factors affecting ID card service life in a manner that is amenable to evaluation using the methods defined or referenced in this part of ISO/IEC 24789.